





#### **60V N-CHANNEL ENHANCEMENT MODE MOSFET**

#### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub> T <sub>A</sub> = 25°C		
60V	66mΩ @ V <sub>GS</sub> = 10V	5.0A		
	97mΩ @ V <sub>GS</sub> = 4.5V	4.1A		

## **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor control
- Backlighting
- DC-DC Converters
- Power management functions

## **Features and Benefits**

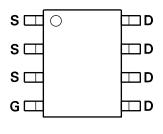
- Low on-resistance
- Fast switching speed
- "Green" component and RoHS compliant (Note 1)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

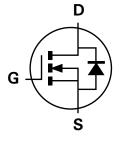
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See diagram below
- Terminals: Finish Matte Tin annealed over Copper lead frame.
   Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)



Top View



Top View



**Equivalent Circuit** 

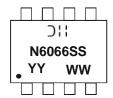
## **Ordering Information** (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN6066SSS-13	N6066SS	13	12	2,500

1. Diodes, Inc. defines "Green" products as those which are RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

# **Marking Information**

Notes:



OH = Manufacturer's Marking
N6066SS = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 09 = 2009)
WW = Week (01 - 53)





## **Maximum Ratings** @T<sub>A</sub> = 25°C unless otherwise specified

	Characteristic		Symbol	Value	Unit
Drain-Source voltage			$V_{DSS}$	60	V
Gate-Source voltage (Note 2)			V <sub>GS</sub>	±20	V
Single Pulsed Avalanche Er	nergy	(Note 7) E <sub>AS</sub> 37.5		mJ	
Single Pulsed Avalanche Current		(Note 7)	I <sub>AS</sub>	5.0	A
Continuous Drain current		(Note 4)		5.0	
	$V_{GS} = 10V$	$T_A = 70^{\circ}C$ (Note 4)	I <sub>D</sub>	4.0	Α
		(Note 3)		3.7	
Pulsed Drain current	V <sub>GS</sub> = 10V	(Note 5)	I <sub>DM</sub>	23	Α
Continuous Source current (	ntinuous Source current (Body diode) (Note		I <sub>S</sub>	4.0	Α
Pulsed Source current (Body diode)		(Note 5)	I <sub>SM</sub>	23	Α

## Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
Power dissipation	(Note 3)	9	1.56 12.5	W	
Linear derating factor	(Note 4)	P <sub>D</sub>	2.81 22.5	mW/°C	
Thermal Decistores, Junction to Ambient	(Note 3)		80.0		
Thermal Resistance, Junction to Ambient	(Note 4)	$R_{ heta JA}$	44.5	°C/W	
Thermal Resistance, Junction to Lead	(Note 6)	$R_{ heta JL}$	37.0		
Operating and storage temperature range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	

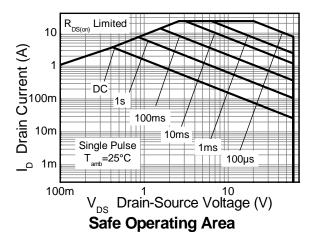
#### Notes:

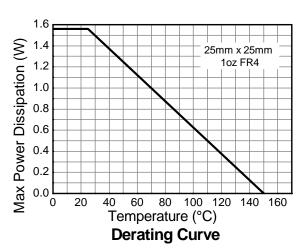
- 2. AEC-Q101  $V_{\text{GS}}$  maximum is  $\pm 16 \text{V}.$
- 3. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 4. Same as note (3), except the device is measured at  $t \le 10$  sec.
- 5. Same as note (3), except the device is pulsed with D= 0.02 and pulse width 300 µs. The pulse current is limited by the maximum junction temperature.
- 6. Thermal resistance from junction to solder-point (at the end of the drain lead). 7. UIS in production with L = 3.0mH,  $I_{AS}$  = 5.0A,  $R_{G}$  = 25 $\Omega$ ,  $V_{DD}$ =50V, starting  $T_{J}$  = 25°C.

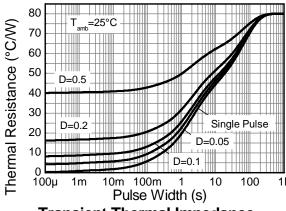


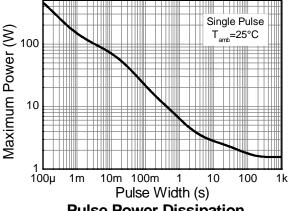


## **Thermal Characteristics**









**Transient Thermal Impedance** 

**Pulse Power Dissipation** 





# Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

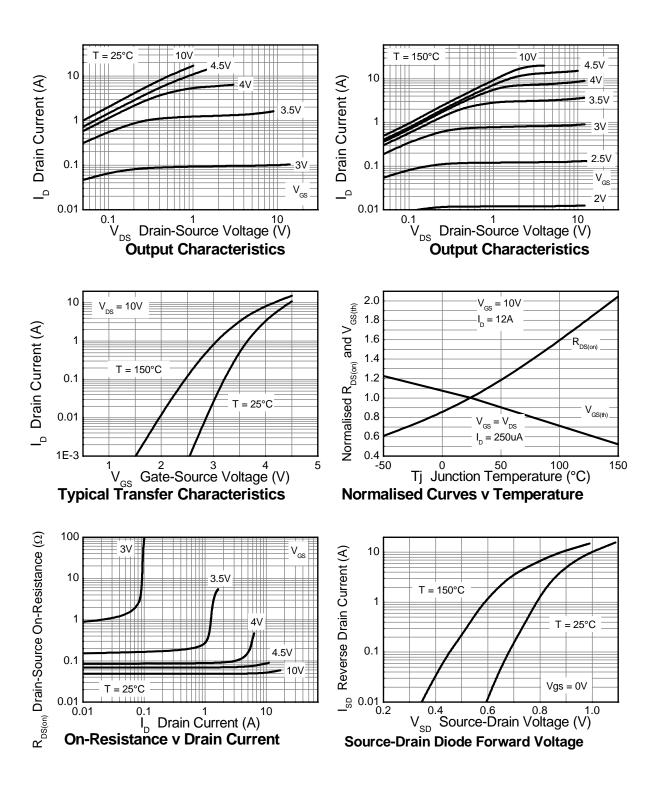
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$I_D = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	0.5	μА	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	_	3.0	V	$I_D = 250 \mu A, V_{DS} = V_{GS}$	
Static Drain-Source On-Resistance (Note 8)	_		0.048	0.066	Ω	$V_{GS} = 10V, I_D = 4.5A$	
Static Dialit-Source Off-Resistance (Note 6)	R <sub>DS</sub> (ON)	_	0.068	0.097	22	$V_{GS} = 4.5V, I_D = 3.5A$	
Forward Transconductance (Notes 8 & 9)	g <sub>fs</sub>	_	19.2	_	S	$V_{DS} = 15V, I_{D} = 6A$	
Diode Forward Voltage (Note 8)	$V_{SD}$	_	0.89	1.15	V	I <sub>S</sub> = 4.5A, V <sub>GS</sub> = 0V	
Reverse recovery time (Note 9)	t <sub>rr</sub>		23	_	ns	1 2 4 A di/dt 100 A/v.o	
Reverse recovery charge (Note 9)	Qrr	_	19.7	_	nC	$I_S = 2.4A$ , di/dt = 100A/ $\mu$ s	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C <sub>iss</sub>	_	502	_	pF	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V f = 1MHz	
Output Capacitance	Coss	_	45.7	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	27.1	_	pF	1 - 1101112	
Total Gate Charge (Note 10)	Qg	_	5.4	_	nC	V <sub>GS</sub> = 4.5V	
Total Gate Charge (Note 10)	Qg	_	10.3	_	nC	V <sub>DS</sub> = 30V	
Gate-Source Charge (Note 10)	Q <sub>gs</sub>	_	1.7	_	nC	$V_{GS} = 10V$ $I_{D} = 4.5A$	
Gate-Drain Charge (Note 10)	Q <sub>gd</sub>	_	3.2	_	nC		
Turn-On Delay Time (Note 10)	t <sub>D(on)</sub>	_	2.7	_	ns		
Turn-On Rise Time (Note 10)	t <sub>r</sub>	—	2.4		ns	$V_{DD} = 30V, V_{GS} = 10V$	
Turn-Off Delay Time (Note 10)	t <sub>D(off)</sub>	—	14.7		ns	$I_D = 1A, R_G \cong 6.0\Omega$	
Turn-Off Fall Time (Note 10)	t <sub>f</sub>	_	5.4	_	ns		

Notes:

- 8. Measured under pulsed conditions. Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$
- For design aid only, not subject to production testing.
   Switching characteristics are independent of operating junction temperatures.

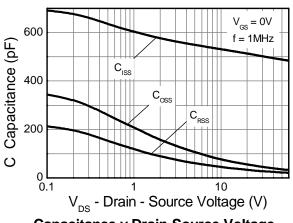


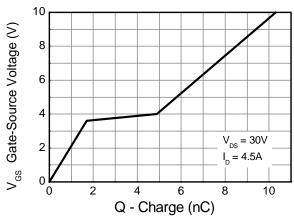
# **Typical Characteristics**





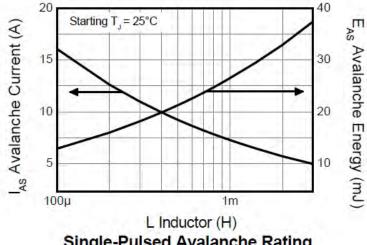
# **Typical Characteristics - continued**





Capacitance v Drain-Source Voltage

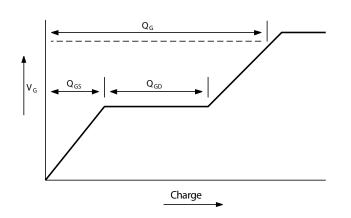
Gate-Source Voltage v Gate Charge

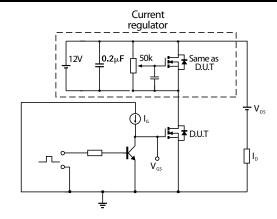


Single-Pulsed Avalanche Rating



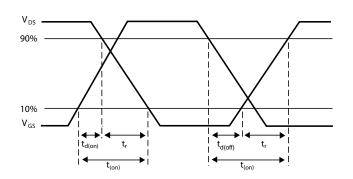
# **Test Circuits**

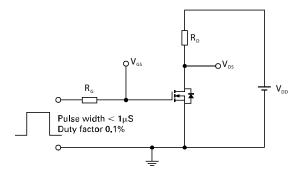




Basic gate charge waveform

Gate charge test circuit



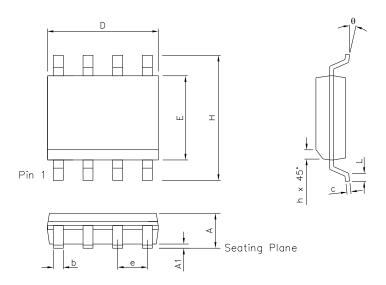


Switching time waveforms

Switching time test circuit

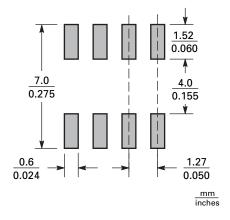


# **Package Outline Dimensions**



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

# **Suggested Pad Layout**







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